Notice of References Cited Application/Control No. 10/726,677 Examiner James A. Dudek Applicant(s)/Patent Under Reexamination CHOO ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2004/0207800 A1	10-2004	Hiruma et al.	349/189
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	D	US-			
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